

L Number	Hits	Search Text	DB	Time stamp
1	91910	((plurality two multi\$3) near2 (pins pads)) same (generat\$3 near8 signal\$1)	USPAT	2004/02/20 10:33
2	429081	generat\$3 near8 signal\$1	USPAT	2004/02/20 10:34
3	1036	((plurality two multi\$3) near2 (pins pads)) same (generat\$3 near8 signal\$1)	USPAT	2004/02/20 10:35
4	24	((plurality two multi\$3) near2 (pins pads)) same (generat\$3 near8 signal\$1) same (high adj voltage)	USPAT	2004/02/20 10:36
-	255	710/14.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/22 20:07
-	76136	semi\$1conduct\$3 near memory	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 10:32
-	255	710/14.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/22 21:44
-	75980	semi\$1conduct\$2 near memory	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/22 21:45
-	9	710/14.ccls. and (semi\$1conduct\$2 near memory)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/22 22:40
-	2	5475647.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/22 22:44
-	2	5963522.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/22 22:53
-	334	((semi\$1conduct\$2 near memory) same (input or output or I/O) near mode)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/22 22:56
-	254	((semi\$1conduct\$2 near memory) same (input or output or I/O) near mode) same signal\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 10:35
-	42	((semi\$1conduct\$2 near memory) same (input or output or I/O) near mode) same signal\$1 same voltage	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/22 22:57
-	1	6477096.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/01/23 10:28
-	4	("5463585" "5793685" "6041002" "6243307").PN.	USPAT	2003/01/23 10:28

-	2	6327198.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/22 14:44
-	6485	(test adj mode) same (pad\$1 pin\$1 terminal\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/02/18 15:00
-	1882	((test adj mode) same (pad\$1 pin\$1 terminal\$1)) same voltage\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/22 15:02
-	4	((((test adj mode) same (pad\$1 pin\$1 terminal\$1)) same voltage\$1) same (external near2 signal\$1)) and 257/\$8.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/22 15:03
-	113	((test adj mode) same (pad\$1 pin\$1 terminal\$1)) same voltage\$1) same (external near2 signal\$1)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/22 15:09
-	624	(test adj mode) near8 (external near2 signals)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/22 15:38
-	567	(test adj mode) near6 (external near2 signals)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/22 15:38
-	111	((test adj mode) near6 (external near2 signals)) same voltage\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/22 15:38
-	11	((test adj mode) near6 (external near2 signals)) same voltage\$1) and 257/\$8.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/22 15:43
-	17	((test adj mode) near6 (external near2 signals)) same voltage\$1) and 714/\$8.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/22 15:43
-	3925	(plural\$3 two multi\$3) near3 (pin\$1 or pad\$1) near8 (test normal mode)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/22 20:12
-	218	(plural\$3 two multi\$3) near3 (pin\$1 or pad\$1) near8 ((test normal) near2 mode)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/22 20:13
-	36	((plural\$3 two multi\$3) near3 (pin\$1 or pad\$1) near8 ((test normal) near2 mode)) same voltage\$1	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2003/08/22 20:14
-	290824	(pad\$1 pin\$1 terminal\$1) same signal\$1	USPAT	2004/02/18 15:03
-	435170	generat\$3 near10 signal\$1	USPAT	2004/02/18 15:05
-	107962	generat\$3 same signal\$1 same (pad\$1 pin\$1 terminal\$1)	USPAT	2004/02/18 16:10

-	40841	((generat\$3 same signal\$1 same (pad\$1 pin\$1 terminal\$1)) same voltage	USPAT	2004/02/18 15:09
-	721	((generat\$3 same signal\$1 same (pad\$1 pin\$1 terminal\$1)) same voltage) and 714/\$.ccls.	USPAT	2004/02/18 15:09
-	2291	((generat\$3 same signal\$1 same (pad\$1 pin\$1 terminal\$1)) same voltage) same semiconductor	USPAT	2004/02/18 15:55
-	66	((generat\$3 same signal\$1 same (pad\$1 pin\$1 terminal\$1)) same voltage) same semiconductor) and 714/\$.ccls.	USPAT	2004/02/18 15:55
-	7	((generat\$3 same signal\$1 same (pad\$1 pin\$1 terminal\$1)) same voltage) same semiconductor) and 710/\$.ccls.	USPAT	2004/02/18 15:49
-	189	6.ab.	USPAT	2004/02/18 15:59
-	9	6.ab. and 714/\$.ccls.	USPAT	2004/02/18 16:00
-	307	6.clm.	USPAT	2004/02/18 15:59
-	12	6.clm. and 714/\$.ccls.	USPAT	2004/02/18 16:00
-	4542	generat\$3 same signal\$1 same set\$4 same mode same (pad\$1 pin\$1 terminal\$1)	USPAT	2004/02/18 16:11
-	368	generat\$3 same signal\$1 same set\$4 same (test adj mode) same (pad\$1 pin\$1 terminal\$1)	USPAT	2004/02/20 10:34
-	13	15.ab.	USPAT	2004/02/18 16:22
-	22	15.clm.	USPAT	2004/02/20 10:32